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Influence of Ga Concentration on the Ordering Process of $\text{Ga}_x\text{In}_{1-x}\text{P}$ Grown on GaAs

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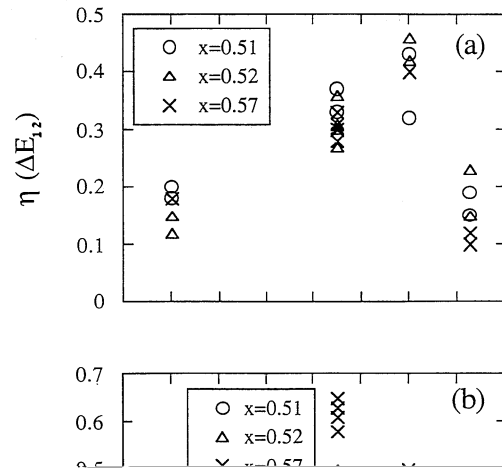
direct band gap and of the SO splitting, respectively. We

temperature using the Ar^+ 5145 Å line with 15 mW power as an exciting source and analyzed using Dilor's micro-Raman spectrograph with an accuracy of $\cong 1.0$ meV on the value of ΔE_{12} . The concentration x was determined from Raman scattering with an accuracy $\Delta x \cong 1\%$.

4. Results and Conclusion

Figure (3) displays the LRO parameter η vs growth temperature where η was extracted by fitting the measured ΔE_{12} to eq. (5) [Fig. 3(a)], and the measured $\Delta E_g(\eta)$ to eq. (4) [Fig. 3(b)]. We observe the usual²⁾ nonmonotonic behavior of η vs T_g in both cases. Composition variations have a small effect on ΔE_{12} and ΔE_g , as predicted by the theory of Wei *et al.*^{4,5)} (Fig. 1 and eq. (4)).

The symbols of Fig. 2 gives the experimental depend-



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